

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	1	"20020099993"	US-PGPUB; USPAT	OR	OFF	2004/05/21 12:11
S2	7	"015332"	USPAT; EPO; JPO; DERWENT	OR	OFF	2004/05/21 12:14
S3	28	IKEDA ADJ SATOSHI.in.	USPAT	OR	OFF	2004/05/21 12:40
S4	272	IKEDA ADJ SATOSHI.in.	USPAT; EPO; JPO; DERWENT	OR	OFF	2004/05/21 12:36
S5	18669	SONY ADJ CORPORATION.as.	USPAT; EPO; JPO; DERWENT	OR	OFF	2004/05/21 12:40
S6	59	(SONY ADJ CORPORATION.as.) and test ADJ pattern	USPAT	OR	OFF	2004/05/21 12:42
S7	11	(SONY ADJ CORPORATION.as.) and test ADJ pattern and semiconductor	USPAT	OR	OFF	2004/05/21 12:46
S8	144	714/738.ccls. and test ADJ pattern and semiconductor	USPAT	OR	OFF	2004/05/21 12:48
S9	80	714/738.ccls. and test ADJ pattern and semiconductor with device	USPAT	OR	OFF	2004/05/21 12:48
S10	69	714/738.ccls. and test ADJ pattern and semiconductor with device and compar\$4	USPAT	OR	OFF	2004/05/21 12:49
S11	44	714/738.ccls. and test ADJ pattern and semiconductor with device and compar\$4 with expected	USPAT	OR	OFF	2004/05/21 12:50
S12	86	714/738.ccls. and test ADJ pattern and (under ADJ test or DUT) and compar\$4 with expected	USPAT	OR	OFF	2004/05/21 13:00
S13	45	714/738.ccls. and test ADJ pattern ADJ generat\$3 and (under ADJ test or DUT) and compar\$4 with expected	USPAT	OR	OFF	2004/05/21 13:04
S14	6	714/738.ccls. and test ADJ pattern with vari\$4 and (under ADJ test or DUT) and compar\$4 with expected	USPAT	OR	OFF	2004/05/21 13:06
S15	4	714/718-739.ccls. and test ADJ pattern with vari\$4 with cycle and (under ADJ test or DUT) and compar\$4 with expected	USPAT	OR	OFF	2004/05/21 13:43
S16	19	714/718-739.ccls. and test ADJ pattern with vari\$4 and (under ADJ test or DUT) and compar\$4 with expected	USPAT	OR	OFF	2004/12/02 18:25

S17	6	("4414665" "4893072" "6219813" "6369601" "6469514" "6479983").PN.	USPAT	OR	OFF	2004/05/21 13:14
S18	3	("4414665" "4893072" "6219813" "6369601" "6469514" "6479983").PN. and variable	USPAT	OR	OFF	2004/05/21 13:14
S19	23	714/719.ccls. and test ADJ pattern and (under ADJ test or DUT) and compar\$4 with expected	USPAT	OR	OFF	2004/05/21 13:18
S20	1	714/719.ccls. and (address with pattern) adj generator and (under ADJ test or DUT) and compar\$4 with expected	USPAT	OR	OFF	2004/05/21 13:21
S21	12	714/719.ccls. and (address and pattern) adj generat\$3 and (under ADJ test or DUT) and compar\$4 with expected	USPAT	OR	ON	2004/05/21 13:26
S22	30	714/718-739.ccls. and (address with pattern) adj generat\$3 and (under ADJ test or DUT) and compar\$4 with expected	USPAT	OR	ON	2004/05/21 13:33
S23	0	714/718-739.ccls. and variable near (read or write) adj cycle and test adj pattern and (under ADJ test or DUT) and compar\$4 with expected	USPAT	OR	ON	2004/05/21 13:35
S24	0	714/718-739.ccls. and variable near (read or write) adj cycle	USPAT	OR	ON	2004/05/21 13:36
S25	5	714/718-739.ccls. and variable near (read or write)	USPAT	OR	ON	2004/05/21 13:36
S26	1	714/718-739.ccls. and variable near execution	USPAT	OR	ON	2004/05/21 13:39
S27	14	714/718-739.ccls. and variable near rate	USPAT	OR	ON	2004/05/21 13:40
S28	2	714/718-739.ccls. and adjustable near rate	USPAT	OR	ON	2004/05/21 13:41
S29	295	714/718-739.ccls. and clock near rate	USPAT	OR	ON	2004/05/21 13:42
S30	3	714/718-739.ccls. and clock near modulat\$4	USPAT	OR	ON	2004/05/21 13:42
S31	16	714/718-739.ccls. and test ADJ pattern and clock adj rate and (under ADJ test or DUT) and compar\$4 with expected	USPAT	OR	OFF	2004/05/21 13:43
S32	2	("6115833" "6243841").PN.	USPAT	OR	OFF	2004/05/21 14:32

S33	67	714/718-739.ccls. and (address and pattern) adj generat\$3 and (under ADJ test or DUT) and compar\$4 with expected	USPAT	OR	ON	2004/05/24 10:07
S34	13	714/718-739.ccls. and test ADJ pattern with vari\$4 with time	USPAT	OR	ON	2004/12/02 18:27
S35	222	714/718-739.ccls. and vari\$4 with clock	USPAT	OR	ON	2004/12/02 18:27
S36	33	714/718-739.ccls. and test ADJ pattern and vari\$4 with period	USPAT	OR	ON	2004/12/02 18:28